

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10597232	KONRATH ET AL.
	Examiner	Art Unit
	JAEYUN LEE	1791

SEARCHED

Class	Subclass	Date	Examiner
156	295, 87	10/28/2009	/JL/
29	832, 840, 25.01	10/28/2009	/JL/
438	118, 119	10/28/2009	/JL
257	E21.505, E21.514	10/28/2009	/JL/

SEARCH NOTES

Search Notes	Date	Examiner
East Search (USPGPUB, USPAT, USOCR, FPRS, EPO, JPO, Derwent, IBM_TDB) and text search	10/28/2009	/JL/
Inventor Search (Edan)	10/28/2009	/JL/
Consulted Primary Examiner (Jeff Aftergut)	10/28/2009	/JL/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/JAEYUN LEE/
Examiner.Art Unit 1791